Search Notes



Application/Control No.	Applicant(s)/Patent Under
	Reexamination

10576373

FUJITA ET AL.

Examiner

Art Unit

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4155

SEARCHED

Class	Subclass	Date	Examiner
297	217.2, 217.3, 284.11, 452.49, 452.55, 452.56, 452.58, 452.59	01/09/2008	PL

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search (eDAN)	01/09/2008	PL
Consulted Joe Edell on Search in 297	01/09/2008	PL
Searched Class 297 (EAST)	01/09/2008	PL
EAST Text Search	01/09/2008	PL
Forward/Backward Citation Search	01/09/2008	

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	ストヒト	RENCE	: SEA	КСП

Class	Subclass	Date	Examiner

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